MDCOG128064B6W-FPTLW	128 x 64	Parallel	LCD Module

Specification	
Version: 1	Date: 03/06/2019

Revision		
1	03/06/2019	First Issue

Display Features		
Resolution	128 x 64	
Appearance	Black on White	
Logic Voltage	3.1V	
Interface	Parallel	
Font Set	N/A	
Display Mode	Transflective	
LC Type	FSTN	
Module Size	58.20 x 44.70 x 3.90mm	
Operating Temperature	-20°C ~ +70°C	
Construction	COG	
LED Backlight	White	

	Box Quantity	Weight / Display
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* - For full design functionality, please use this specification in conjunction with the ST7565P specification. (Provided Separately)

Display Accessories	
Part Number	Description

Optional Variants	
Appearances	Voltage

General Specification

The Features of the Module is description as follow:

- Number of dots: 128 x 64

- Module dimension: 58.2 x 44.7 x 3.9(MAX) mm

- View area: 52.0 x 33.5 mm

- Active area: 47.76 x 30.29 mm

- Dot size: 0.40 x 0.35 mm

- Dot pitch: 0.42 x 0.37 mm

- LCD type: FSTN Positive Transflective

- Duty: 1/64

- View direction: 6 o'clock

- Backlight Type: LED, White

- IC: ST7565P

Interface Pin Function

Pin No.	Symbol	I/O	Description
1	VDD	_	Power supply pin for logic.
2	VSS	_	Ground pin, connected to 0V
3	/CS1	I	Chip select input pin. Interface access is enabled when CS1B is "L" and CB2 is "H". When chip is on-active (CS1B="H" or CS2="L"), D[7:0] pins are high impedance.
4	CS2		
5	/RES	I	Hardware reset input pin. When RSTB is "L", internal initialization is executed and the internal registers will be initialized.
6	A0	I	It determines whether the access is related to data or command. A0="H": Indicates that signals on D[7:0] are display data. A0="L": Indicates that signals on D[7:0] are command.
7	R/W	I	Read/Write execution control pin. When PSB is "H", See table below. RWR is not used in serial interface and should fix to "H" by VDD.
8	E	I	Read/Write execution control pin. When PSB is "H", See table below. ERD is not used in serial interface and should fix to "H" by VDD.
9-16	D0-D7	I/O	Data bus line

Pin 7 (R/W) detail:

C86	MPU Type	RWR	Description
H	6800 series	R/W	Read/Write control input pin. R/W="H": read. R/W="L": write.
L	8080 series	/WR	Write enable input pin. Signals on D[7:0] will be latched at the rising edge of /WR signal.

Pin 8 (E) detail:

C86	MPU Type	ERD	Description
H	6800 series	E	Read/Write control input pin. R/W="H": When E is "H", D[7:0] are in output mode. R/W="L": Signals on D[7:0] are latched at the falling edge of E signal.
L	8080 series	/RD	Read enable input pin. When /RD is "L", D[7:0] are in output mode.

17	C86	I	C86 selects the microprocessor type in parallel interface mode.

C86 selects the microprocessor type in parallel interface mode.

PSB	C86	Selected Interface
"H"	"H"	Parallel 6800 Series MPU Interface
"H"	"L"	Parallel 8080 Series MPU Interface
"L"	"X"	Serial 4-Line SPI Interface

Please refer to "APPLICATION NOTES" and "Microprocessor Interface" (Section 6) for detailed connection of the selected interface.

18	P/S	I	PSB selects the interface type: Serial or Parallel.

Contour Drawing

PIN NO.	SYMBOL
1	VDD
2	VSS
3	/CS1
4	CS2
5	/RES
6	A0
7	R/W
8	E
9	D0
10	D1
11	D2
12	D3
13	D4
14	D5
15	D6
16	D7
17	C86
18	P/S

DOTS:128X64

Pull tape

Component Area

CONDUCTIVE SIDE

Siffener

UV Glue

DOT SIZE
SCALE 10/1

The non-specified tolerance of dimension is ±0.3mm.
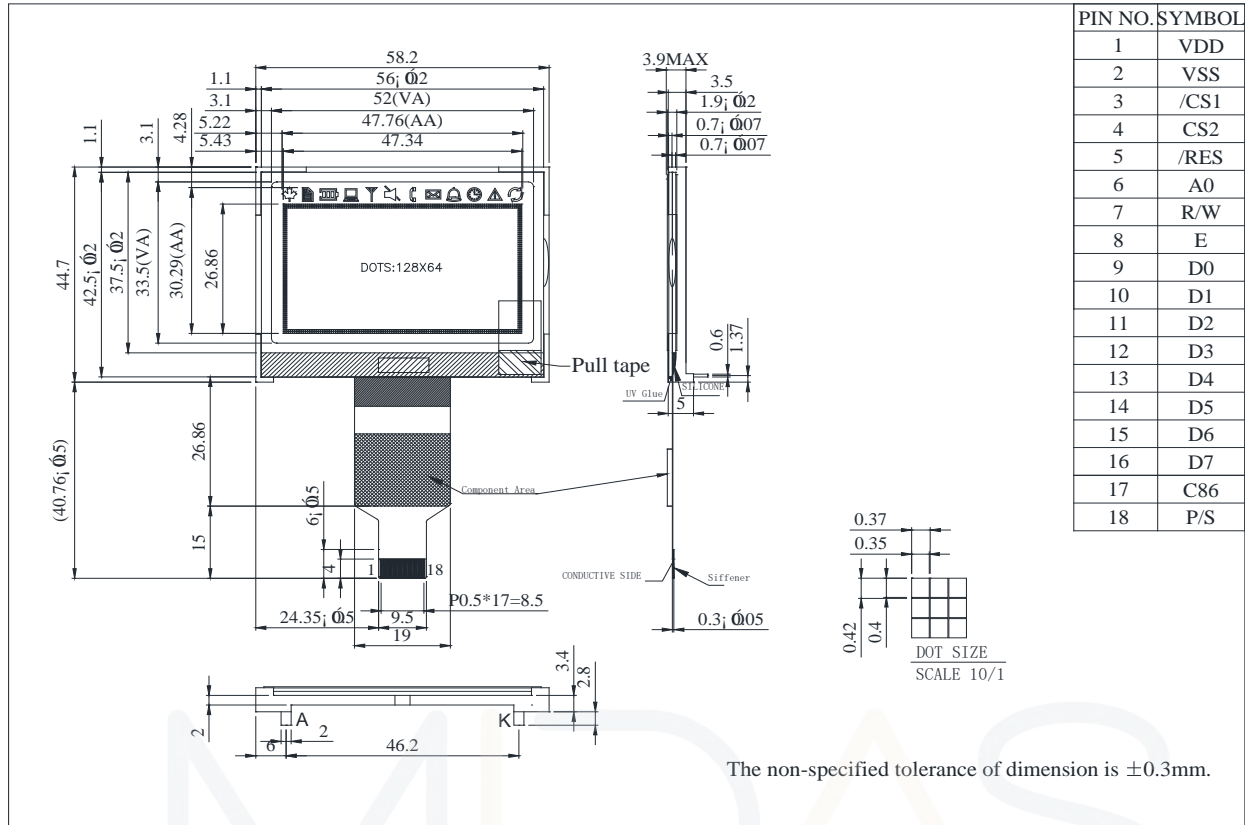
Optical Characteristics

Item	Symbol	Condition	Min	Typ	Max	Unit
View Angle	θ	CR≧2	0	―	30	ψ= 180°
	θ	CR≧2	0	―	60	ψ= 0°
	θ	CR≧2	0	―	45	ψ= 90°
	θ	CR≧2	0	―	45	ψ= 270°
Contrast Ratio	CR	―	―	5	―	―
Response Time	T rise	―	―	200	300	ms
	T fall	―	―	250	350	ms

Definition of Operation Voltage (Vop)   **Definition of Response Time (Tr , Tf)**
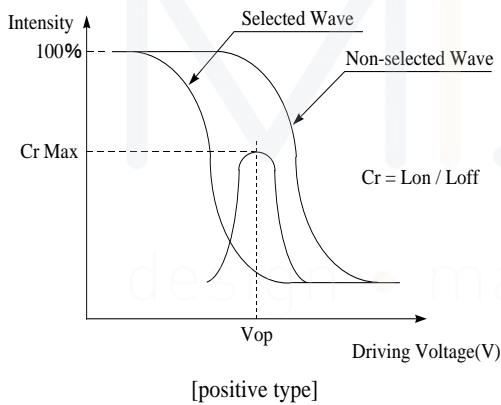
Intensity
100%
Selected Wave
Non-selected Wave
Cr Max
Cr = Lon / Loff
Vop
Driving Voltage(V)
[positive type]

Non-selected Condition
Selected Condition
Non-selected Condition
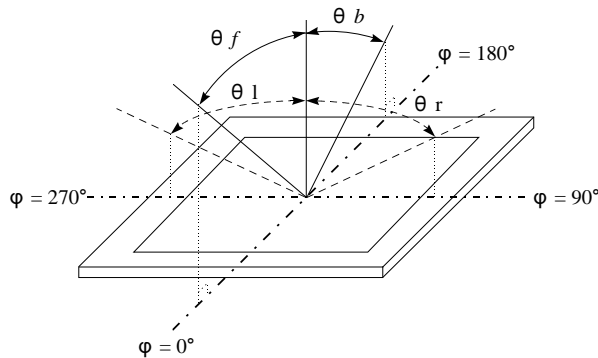Intensity
100%
90%
10%
Tr
Tf
【 Positive type】
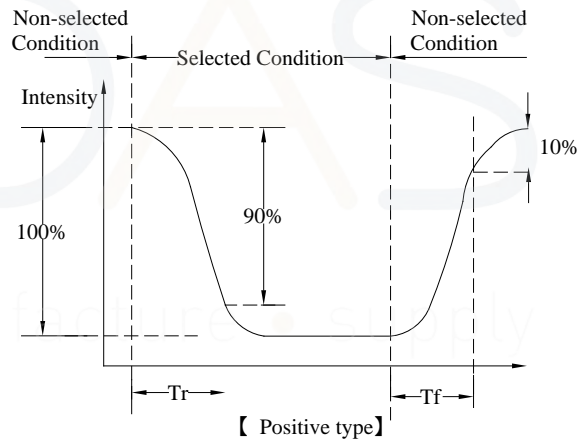
Conditions :

Operating Voltage : Vop   Viewing Angle(θ , φ) : 0° ,   0°

Frame Frequency : 64 HZ Driving Waveform : 1/N duty , 1/a bias

Definition of viewing angle(CR≧2)

θ f
θ b
φ = 180°
θ l
θ r
φ = 270°
φ = 90°
φ = 0°

Absolute Maximum Ratings

Item	Symbol	Min	Typ	Max	Unit
Operating Temperature	T_{OP}	-20	—	+70	℃
Storage Temperature	T_{ST}	-30	—	+80	℃
Power Supply Voltage	VDD	-0.3	—	3.6	V
Power supply voltage (VDD standard)	V0, VOUT	-0.3	—	14.5	V
Power supply voltage (VDD standard)	V1, V2, V3, V4	-0.3	—	V0+0.3	V

Electrical Characteristics

Item	Symbol	Condition	Min.	Typ.	Max.	Unit
Supply Voltage For Logic	V_{DD}-V_{SS}	—	3.0	—	3.3	V
Supply Voltage For LCD	V_{OP}	Ta=-20℃	—	—	—	V
		Ta=25℃	8.3	8.5	8.7	V
		Ta=70℃	—	—	—	V
Input High Volt.	V_{IH}	—	0.8V_{DD}	—	V_{DD}	V
Input Low Volt.	V_{IL}	—	V_{SS}	—	0.2V_{DD}	V
Output High Volt.	V_{OH}	—	0.8V_{DD}	—	V_{DD}	V
Output Low Volt.	V_{OL}	—	V_{DD}	—	0.2V_{DD}	V
Supply Current	I_{DD}	V_{DD}=3.3V	—	1	2	mA

Please kindly consider to design the Vop to be adjustable while programing the software to match LCD contrast tolerance.

Backlight Information

Specification

PARAMETER	SYMBOL	MIN	TYP	MAX	UNIT	TEST CONDITION
Supply Current	ILED	36	48	60	mA	V= 3.5V
Supply Voltage	V	—	3.5	—	V	—
Reverse Voltage	VR	—	—	5	V	—
Color coordinate	X	0.25	0.28	0.31	—	ILED=48mA
	Y	0.27	0.30	0.33		
Luminance (Without LCD)	IV	688	860	—	CD/M^2	ILED=48mA
LED Life Time	—	30K	—	—	Hr.	ILED=48mA 25℃,50-60%RH, (Note 2)
Color	White					

Note: The LED of B/L is drive by current only, drive voltage is for reference only. drive voltage can make driving current under safety area (current between minimum and maximum).

Note 1: Supply current minimum value is only for reference since LED brightness efficiency keeps enhancing. Current consumption becomes less and less to achieve the same luminance.

Note2:30K hours is only an estimate for reference.
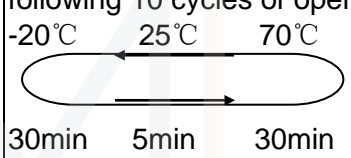
LED B\L Drive Method
1.Drive from A , K
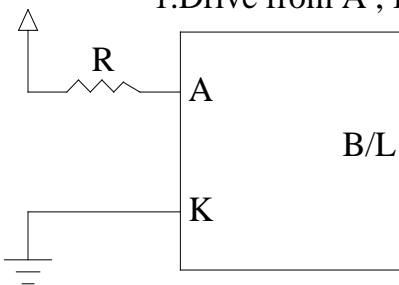
Reliability

Content of Reliability Test (Wide temperature, -20℃~70℃)

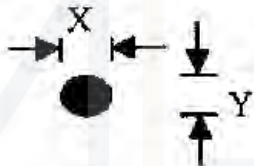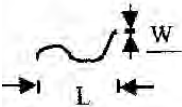| Environmental Test			
Test Item	**Content of Test**	**Test Condition**	**Note**
High Temperature storage	Endurance test applying the high storage temperature for a long time.	80℃ 200hrs	2
Low Temperature storage	Endurance test applying the low storage temperature for a long time.	-30℃ 200hrs	1,2
High Temperature Operation	Endurance test applying the electric stress (Voltage & Current) and the thermal stress to the element for a long time.	70℃ 200hrs	――
Low Temperature Operation	Endurance test applying the electric stress under low temperature for a long time.	-20℃ 200hrs	1
High Temperature/ Humidity storage	The module should be allowed to stand at 40℃,90%RH max For 96hrs under no-load condition excluding the polarizer, Then taking it out and drying it at normal temperature.	40℃,90%RH 96hrs	1,2
Thermal shock resistance	The sample should be allowed stand the following 10 cycles of operation -20℃ 25℃ 70℃ 30min 5min 30min 1 cycle	-20℃/70℃ 10 cycles	――
Vibration test	Endurance test applying the vibration during transportation and using.	Total fixed amplitude : 1.5mm Vibration Frequency : 10~55Hz One cycle 60 seconds to 3 directions of X,Y,Z for Each 15 minutes	3
Static electricity test	Endurance test applying the electric stress to the terminal.	VS=±600V(contact), ±800v(air), RS=330Ω CS=150pF 10 times	――

Note1: No dew condensation to be observed.

Note2: The function test shall be conducted after 4 hours storage at the normal Temperature and humidity after remove from the test chamber.
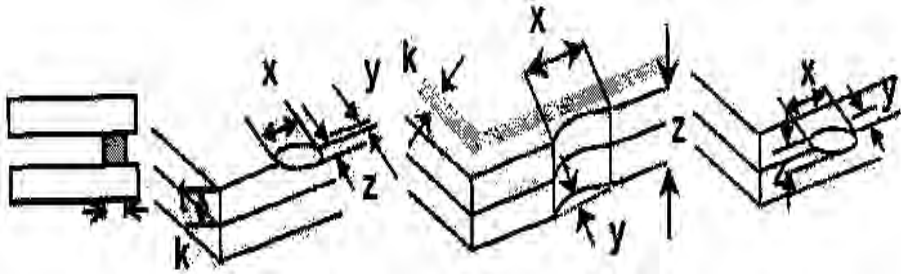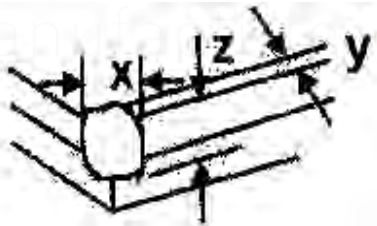
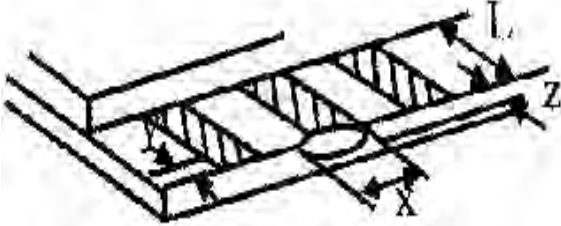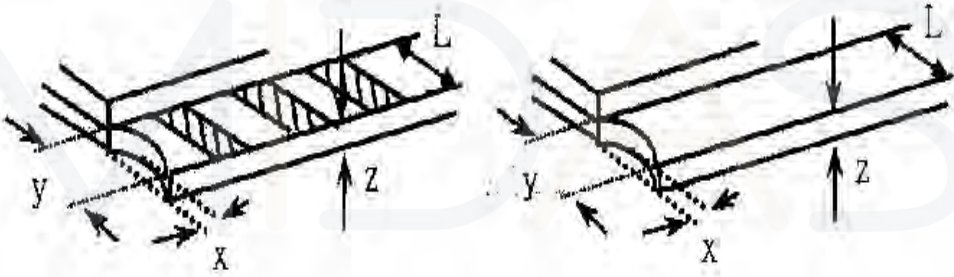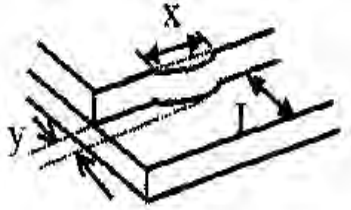**Note3: The packing have to including into the vibration testing.**

Inspection specification

NO	Item	Criterion	AQL
01	Electrical Testing	1.1 Missing vertical, horizontal segment, segment contrast defect. 1.2 Missing character , dot or icon. 1.3 Display malfunction. 1.4 No function or no display. 1.5 Current consumption exceeds product specifications. 1.6 LCD viewing angle defect. 1.7 Mixed product types. 1.8 Contrast defect.	0.65
02	Black or white spots on LCD (display only)	2.1 White and black spots on display $\leqq0.25$mm, no more than three white or black spots present. 2.2 Densely spaced: No more than two spots or lines within 3mm	2.5
03	LCD black spots, white spots, contamination (non-display)	3.1 Round type : As following drawing $\Phi=(x + y) / 2$ | SIZE	Acceptable Q TY
---	---
$\Phi\leqq0.10$	Accept no dense
$0.10<\Phi\leqq0.20$	2
$0.20<\Phi\leqq0.25$	1
$0.25<\Phi$	0		2.5

3.2 Line type : (As following drawing)

Length	Width	Acceptable Q TY
---	$W\leqq0.02$	Accept no dense
$L\leqq3.0$	$0.02<W\leqq0.03$	2
$L\leqq2.5$	$0.03<W\leqq0.05$	
---	$0.05<W$	As round type

AQL 2.5

| 04 | Polarizer bubbles | If bubbles are visible, judge using black spot specifications, not easy to find, must check in specify direction. | 2.5 |

Size Φ	Acceptable Q TY
$\Phi\leqq0.20$	Accept no dense
$0.20<\Phi\leqq0.50$	3
$0.50<\Phi\leqq1.00$	2
$1.00<\Phi$	0
Total Q TY	3

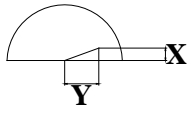| NO	Item	Criterion	AQL
05	Scratches	Follow NO.3 LCD black spots, white spots, contamination	
06	Chipped glass	Symbols Define: x: Chip length　　y: Chip width　　z: Chip thickness k: Seal width　　t: Glass thickness　a: LCD side length L: Electrode pad length: 6.1 General glass chip : 6.1.1 Chip on panel surface and crack between panels: 6.1.2 Corner crack:	2.5

6.1.1 table:

z: Chip thickness	y: Chip width	x: Chip length
$Z \leqq 1/2t$	Not over viewing area	$x \leqq 1/8a$
$1/2t < z \leqq 2t$	Not exceed 1/3k	$x \leqq 1/8a$

⊙If there are 2 or more chips, x is total length of each chip.

6.1.2 table:

z: Chip thickness	y: Chip width	x: Chip length
$Z \leqq 1/2t$	Not over viewing area	$x \leqq 1/8a$
$1/2t < z \leqq 2t$	Not exceed 1/3k	$x \leqq 1/8a$

⊙If there are 2 or more chips, x is the total length of each chip.

NO	Item	Criterion	AQL
06	Glass crack	Symbols : x: Chip length　　　y: Chip width　　z: Chip thickness k: Seal width　　　　t: Glass thickness　a: LCD side length L: Electrode pad length 6.2 Protrusion over terminal : 6.2.1 Chip on electrode pad : <table><tr><td>y: Chip width</td><td>x: Chip length</td><td>z: Chip thickness</td></tr><tr><td>y≦0.5mm</td><td>x≦1/8a</td><td>0 ＜ z ≦ t</td></tr></table> 6.2.2 Non-conductive portion: <table><tr><td>y: Chip width</td><td>x: Chip length</td><td>z: Chip thickness</td></tr><tr><td>y≦ L</td><td>x≦1/8a</td><td>0 ＜ z ≦ t</td></tr></table> ⊙If the chipped area touches the ITO terminal, over 2/3 of the ITO 　must remain and be inspected according to electrode terminal 　specifications. ⊙If the product will be heat sealed by the customer, the alignment 　mark not be damaged. 6.2.3 Substrate protuberance and internal crack. <table><tr><td>y: width</td><td>x: length</td></tr><tr><td>y≦1/3L</td><td>x ≦ a</td></tr></table>	2.5

NO	Item	Criterion	AQL
07	Cracked glass	The LCD with extensive crack is not acceptable.	2.5
08	Backlight elements	8.1 Illumination source flickers when lit.	0.65
		8.2 Spots or scratched that appear when lit must be judged. Using LCD spot, lines and contamination standards.	2.5
		8.3 Backlight doesn't light or color wrong.	0.65
09	Bezel	9.1 Bezel may not have rust, be deformed or have fingerprints, stains or other contamination.	2.5
		9.2 Bezel must comply with job specifications.	0.65
10	PCB、COB	10.1 COB seal may not have pinholes larger than 0.2mm or contamination.	2.5
		10.2 COB seal surface may not have pinholes through to the IC.	
		10.3 The height of the COB should not exceed the height indicated in the assembly diagram.	2.5
			0.65
		10.4 There may not be more than 2mm of sealant outside the seal area on the PCB. And there should be no more than three places.	2.5
		10.5 No oxidation or contamination PCB terminals.	
		10.6 Parts on PCB must be the same as on the production characteristic chart. There should be no wrong parts, missing parts or excess parts.	2.5
			0.65
		10.7 The jumper on the PCB should conform to the product characteristic chart.	
		10.8 If solder gets on bezel tab pads, LED pad, zebra pad or screw hold pad, make sure it is smoothed down.	0.65
		10.9 The Scraping testing standard for Copper Coating of PCB	2.5
		X * Y<=2mm2	2.5
11	Soldering	11.1 No un-melted solder paste may be present on the PCB.	2.5
		11.2 No cold solder joints, missing solder connections, oxidation or icicle.	2.5
		11.3 No residue or solder balls on PCB.	2.5
		11.4 No short circuits in components on PCB.	0.65

NO	Item	Criterion	AQL
12	General appearance	12.1 No oxidation, contamination, curves or, bends on interface Pin (OLB) of TCP.	2.5
		12.2 No cracks on interface pin (OLB) of TCP.	0.65
		12.3 No contamination, solder residue or solder balls on product.	2.5
		12.4 The IC on the TCP may not be damaged, circuits.	2.5
		12.5 The uppermost edge of the protective strip on the interface pin must be present or look as if it cause the interface pin to sever.	2.5
		12.6 The residual rosin or tin oil of soldering (component or chip component) is not burned into brown or black color.	2.5
		12.7 Sealant on top of the ITO circuit has not hardened.	2.5
		12.8 Pin type must match type in specification sheet.	0.65
		12.9 LCD pin loose or missing pins.	0.65
		12.10 Product packaging must the same as specified on packaging specification sheet.	0.65
		12.11 Product dimension and structure must conform to product specification sheet.	0.65
		12.12 Visual defect outside of VA is not considered to be rejection.	

Precautions in use of LCD Modules

(1) Avoid applying excessive shocks to the module or making any alterations or modifications to it.

(2) Don't make extra holes on the printed circuit board, modify its shape or change the components of LCD module.

(3) Don't disassemble the LCM.

(4) Don't operate it above the absolute maximum rating.

(5) Don't drop, bend or twist LCM.

(6) Soldering: only to the I/O terminals.

(7) Storage: please storage in anti-static electricity container and clean environment.

(8) MIDAS have the right to change the passive components, including R3,R6 & backlight adjust resistors. (Resistors,capacitors and other passive components will have different appearance and color caused by the different supplier.)

(9) MIDAS have the right to change the PCB Rev. (In order to satisfy the supplying stability, management optimization and the best product performance...etc, under the premise of not affecting the electrical characteristics and external dimensions, MIDAS have the right to modify the version.)

(10) To ensure the stability of the display screen, please apply screen saver after showing 30 mins of fixed display content.

Material List of Components for RoHs

1. MIDAS hereby declares that all of or part of products (with the mark "#"in code), including, but not limited to, the LCM, accessories or packages, manufactured and/or delivered to your company (including your subsidiaries and affiliated company) directly or indirectly by our company (including our subsidiaries or affiliated companies) do not intentionally contain any of the substances listed in all applicable EU directives and regulations, including the following substances.

   Exhibit A：The Harmful Material List

Material	(Cd)	(Pb)	(Hg)	(Cr6+)	PBBs	PBDEs
Limited Value	100 ppm	1000 ppm	1000 ppm	1000 ppm	1000 ppm	1000 ppm
Above limited value is set up according to RoHS.						

2. Process for RoHS requirement：(only for RoHS inspection)
   (1) Use the Sn/Ag/Cu soldering surface；the surface of Pb-free solder is rougher than we used before.
   (2) Heat-resistance temp.：
       Reflow：250℃,30 seconds Max.；
       Connector soldering wave or hand soldering：320℃, 10 seconds max.
   (3) Temp. curve of reflow, max. Temp.：235±5℃；
       Recommended customer's soldering temp. of connector：280℃, 3 seconds.

Recommendable Storage

1. Place the panel or module in the temperature 25°C±5°C and the humidity below 65% RH
2. Do not place the module near organics solvents or corrosive gases.
3. Do not crush, shake, or jolt the module.